Test Report issued under the responsibility of:





TEST REPORT IEC 60947-2 Low-voltage switchgear and controlgear - Part 2: Circuit-breakers					
Report Reference No	00901-CB201200C-066336				
Total number of pages	174				
CB Testing Laboratory	Shanghai Testin in the store of the strute for Electrical Equipment (STIEE)				
Address:	505 Wu Ning Rd. Shanghai 200063, P.R. CHINA				
Applicant's name:	Zhejiang Tengen Electrics Co.,Ltd.				
Address:	TENGEN Industry Zone, Liushi, Yueqing, Zhejiang Province, P.R.China				
Test specification:					
Standard:	IEC 60947-2:2006 (Fourth Edition) + A1: 2009 + A2: 2013				
Test procedure:	CB scheme				
Non-standard test method	standard test method N/A				
Test Report Form No	IEC60947_2G				
Test Report Form(s) Originator:	DEKRA Certification BV				
Master TRF:	Dated 2013-11				
Copyright © 2013 IEC System for Co (IECEE), Geneva, Switzerland. All rig	onformity Testing and Certification of Electrical Equipment ghts reserved.				
	in part for non-commercial purposes as long as the IECEE is acknowledged as EE takes no responsibility for and will not assume liability for damages resulting from terial due to its placement and context.				
procedure shall be removed.	CEE members, the IECEE/IEC logo and the reference to the CB Scheme ort unless signed by an approved CB Testing Laboratory and appended B in accordance with IECEE 02.				
Test item description:	Air Circuit Breaker				
Trade Mark:	N/A				
Manufacturer:	Zhejiang Tengen Electrics Co.,Ltd.				
	TENGEN Industry Zone, Liushi, Yueqing, Zhejiang Province, P.R.China				
Model/Type reference:	TGW45-3200, TGW45-4000				
Ratings:	Ue: AC415V,AC690V In: 2000A,2500A,2900A,3150A,3200A(TGW45-3200 3P/4P); 4000A(TGW45-4000 3P)				

		•	
Test	ing procedure and testing location:		
X	CB Testing Laboratory:	Shanghai Testing & Inspection Institute for Electrical Equipment (STIEE)	
Testing location/ address		505 Wu Ning Rd. Shanghai 200063, P.R. CHINA	
	Tested by (name + signature):	Cheng Yanmin	转度数
	Approved by (name + signature):	Wei Qingyuan	程序数 魏氏媛
	Testing procedure: TMP	N/A	
Test	ing location/ address	N/A	
	Tested by (name + signature):	N/A	
	Approved by (name + signature):	N/A	
	Testing procedure: WMT	N/A	
Testing location/ address:		N/A	
	Tested by (name + signature):	N/A	
	Witnessed by (name + signature):	N/A	
	Approved by (name + signature):	N/A	
	Testing procedure: SMT	N/A	
Test	ing location/ address	N/A	
	Tested by (name + signature):	N/A	
	Approved by (name + signature):	N/A	
	Supervised by (name + signature) :	N/A	

Page 2 of 174